Notice of References Cited Application/Control No. 10/527,460 Examiner Leslie R. Deak Applicant(s)/Patent Under Reexamination BEDEN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,132,616	10-2000	Twardowski et al.	210/646
*	В	US-5,470,483	11-1995	Bene et al.	210/741
*	С	US-4,770,769	09-1988	Schael, Wilfried	210/96.2
*	D	US-5,783,072	07-1998	Kenley et al.	210/195.2
*	E	US-2006/0254982	11-2006	Kopperschmidt, Pascal	210/646
*	F	US-2006/0237351	10-2006	Felding, Anders	210/101
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q				,	
	R					
	S				·	
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	٧							
	w							
	×							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.